Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/706,138	SAKUNO, KEIICHI		
Examiner	Art Unit		
Khanh V. Nguyen	2817		

SEARCHED						
Cla	ss	Subclass	Date		Examiner	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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